## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10581036	SHIMIZU ET AL.
Examiner	Art Unit
TIMOTHY PHAM	2617

SEARCHED			
Class	Subclass	Date	Examiner
370	345	5/22/2009	T.Pham
455	127.1, 127.2	5/22/2009	T.Pham
455	232.1; 234.1; 234.2	12/3/2010	T.Pham
375	345	12/3/2010	T.Pham

SEARCH NOTES		
Search Notes	Date	Examiner
East; Text Search (USPAT; US-PGPUB; DERWENT); Plus Search;	5/22/2009	T.Pham
Inventor Search; See search history printout.		
Updated Search; See search history printout	11/20/2009	T.Pham
Updated search; See search history printout	2/16/2010	T.Pham
Updated Search; See search history printout	6/30/2010	T.Pham
Consulted with Ed Urban (SPE 2618) for search strategy	12/1/2010	T.Pham
Consulted with Nguyen Vo (Primary Examiner 2618) for search strategy	12/3/2010	T.Pham
Updated search;	12/3/2010	T.Pham

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
Claim search	(((gain near4 estimat\$5) with (frame or (time near slot) or interval or period)) same ((calibrat\$5 or tun\$4 or adjust\$4) near6 ("DC" or voltage) near3 offset) same(maximum near2 gain)).clm.	12/3/2010	T.Pham

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